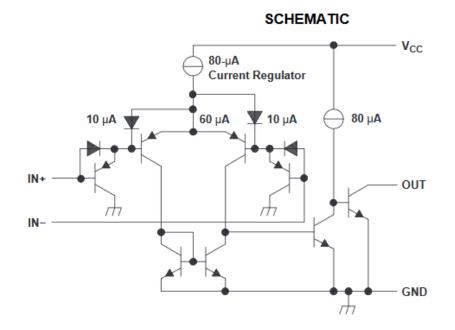


# Functional Safety FIT Rate, Failure Mode Distribution TL331-Q1

## SINGLE DIFFERENTIAL COMPARATOR



| FIT IEC TR 62380 / ISO 26262-11 (1) | Per 10^9 Hours (FIT) |
|-------------------------------------|----------------------|
| Total FIT Rate                      | 4                    |
|                                     |                      |
| Die FIT Rate                        | 2                    |
| Package FIT Rate                    | 2                    |

| FIT Siemens Norm SN29500 (2) |                      |                         |                                  |
|------------------------------|----------------------|-------------------------|----------------------------------|
| Table                        | Category             | Ref FIT $\lambda_{ref}$ | Ref Virtual Τj θ <sub>vi,1</sub> |
| 4                            | Bipolar Op Amp, Comp | 3 FIT                   | 55 C                             |

| Failure Modes                       | Failure Mode Distribution (%) |
|-------------------------------------|-------------------------------|
| Out open (HIZ)                      | 15%                           |
| Out saturate high                   | 25%                           |
| Out saturate low                    | 25%                           |
| Out functional not in specification | 30%                           |
| Short circuit any two pins          | 5%                            |

### (1) Failure Rate, Mission Profile and Failure Modes Distribution

The failure rate and mission profile information come from reliability modeling for Integrated circuits in Reliability<br/>data handbook IEC TR 62380 and ISO 26262 Part 11Mission Profile: Motor Control from Table 11Power dissipation: 5 mWClimate type: World-wide Table 8Package factor lambda 3 Table 17bSubstrate Material: FR4EOS FIT rate assumed = 0

#### (2) Reference failure rate, Virtual (equivalent) junction temperature

The reference failure rate and virtual junction temperature come from Siemens Norm SN29500-2 tables 1-5. Failure rate for user mission profile is calculated using the reference failure rate and virtual junction temperature and following the calculation information in SN29500-2 section 4.

The failure mode distribution estimation comes from the combination of common failure modes listed in standards such as IEC 61508 and ISO 26262, the ratio of sub-circuit function size and complexity and from best engineering judgment. The failure rates listed reflect random failure events and do not include failures due to misuse or over stress.

TL331-Q1 is a catalog product and not compliant to ISO-26262 standards.

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